Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/534,012	NAUKKARINEN ET AL.
Examiner	Art Unit
Tu X. Nguyen	2618

SEARCHED					
Class	Subclass	Date	Examiner		
701	220,224	9/26/2007	TN		
342	357.01,09				
	357.1				
702	150,33				
455	456.1,2,3				
	404.2				
	414.2		:-		
	440				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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